

| <b>Search Notes</b><br> | Application/Control No. | Applicant(s)/Patent under Reexamination |  |
|--|-------------------------|---|--|
|  | 09/882,581              | BRONSTEIN ET AL.                        |  |
|  | Examiner                | Art Unit                                |  |
|  | Ronald E. Williams      | 2121                                    |  |

**SEARCHED**

| SEARCH NOTES<br>(INCLUDING SEARCH STRATEGY)                              |           |      |
|--|-----------|------|
|  | DATE      | EXMR |
| EAST<br>Keyword Search: Fault Management, Fault Tolerance, Health, Bayes | 1/24/2006 | RW   |
| Google<br>Keyword Search: Fault Management, Bayesian, Bayes, Application | 1/26/2006 | RW   |
| EAST<br>Keyword Search: Probabilistic, Health, Bayes, Bayesian           | 1/24/2006 | RW   |
|  |           |      |
|  |           |      |
|  |           |      |
|  |           |      |
|  |           |      |